



5STF 28H2060

Fast Thyristor

Properties

- Amplifying gate
- High operational capability
- Optimized turn-off parameters

Applications

- Power switching applications

Key Parameters

V_{DRM}, V_{RRM}	= 2 000	V
I_{TAV}	= 2 667	A
I_{TSM}	= 46.5	kA
V_{TO}	= 1.198	V
r_T	= 0.103	m Ω
t_q	= 60	μ s

Types

	V_{RRM}, V_{DRM}
5STF 28H2060	2 000 V
Conditions: $T_j = -40 \div 125$ °C, half sine waveform, $f = 50$ Hz, note 1	

Mechanical Data

F_m	Mounting force	50 \pm 5 kN
m	Weight	0.93 kg
D_s	Surface creepage distance	36 mm
D_a	Air strike distance	15 mm

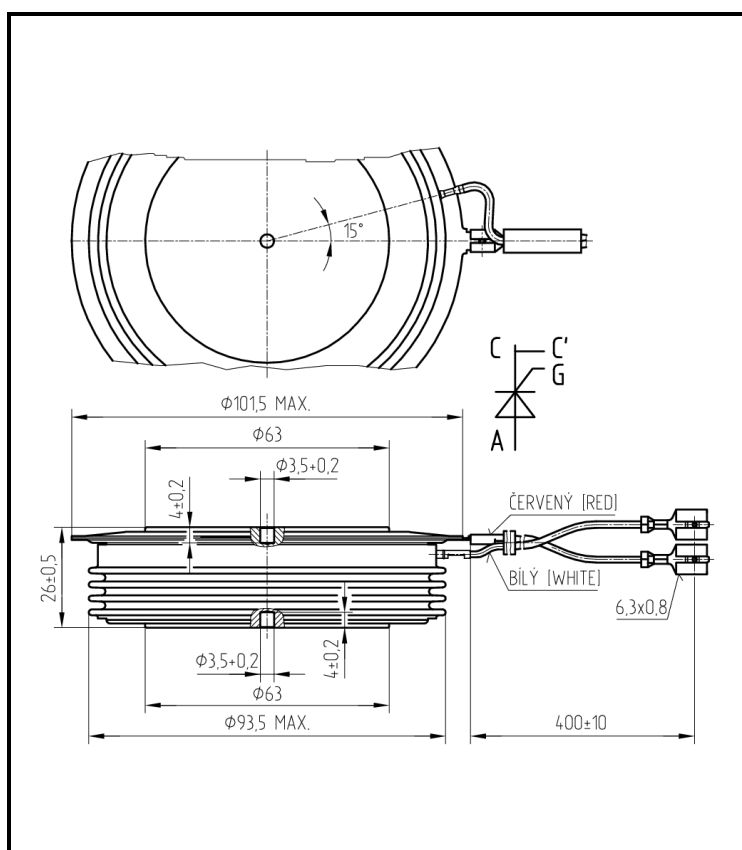


Fig. 1 Case



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Maximum Ratings		Maximum Limits	Unit
V_{RRM} V_{DRM}	Repetitive peak reverse and off-state voltage $T_j = -40 \div 125 \text{ }^\circ\text{C}$, note 1	2 000	V
I_{TRMS}	RMS on-state current $T_c = 70 \text{ }^\circ\text{C}$, half sine waveform, $f = 50 \text{ Hz}$	4 189	A
I_{TAVm}	Average on-state current $T_c = 70 \text{ }^\circ\text{C}$, half sine waveform, $f = 50 \text{ Hz}$	2 667	A
I_{TSM}	Peak non-repetitive surge half sine pulse, $V_R = 0 \text{ V}$	$t_p = 10 \text{ ms}$ 46 500 $t_p = 8.3 \text{ ms}$ 49 700	A
$\hat{P}t$	Limiting load integral half sine pulse, $V_R = 0 \text{ V}$	$t_p = 10 \text{ ms}$ 10 810 000 $t_p = 8.3 \text{ ms}$ 10 250 000	A²s
$(di_T/dt)_{cr}$	Critical rate of rise of on-state current $I_T = I_{TAVm}$, half sine waveform, $f = 50 \text{ Hz}$, $V_D = 2/3 V_{DRM}$, $t_r = 0.3 \text{ } \mu\text{s}$, $I_{GT} = 2 \text{ A}$	800	A/μs
$(dv_D/dt)_{cr}$	Critical rate of rise of off-state voltage $V_D = 2/3 V_{DRM}$	1 000	V/μs
P_{GAVm}	Maximum average gate power losses	3	W
I_{FGM}	Peak gate current	10	A
V_{FGM}	Peak gate voltage	12	V
V_{RGM}	Reverse peak gate voltage	10	V
$T_{jmin} - T_{jmax}$	Operating temperature range	-40 \div 125	$^\circ\text{C}$
$T_{stgmin} - T_{stgmax}$	Storage temperature range	-40 \div 125	$^\circ\text{C}$

Unless otherwise specified $T_j = 125 \text{ }^\circ\text{C}$

Note 1: De-rating factor of 0.13% V_{RRM} or V_{DRM} per $^\circ\text{C}$ is applicable for T_j below $25 \text{ }^\circ\text{C}$

Characteristics			Value			Unit
			min.	typ.	max.	
V_{TM}	Maximum peak on-state voltage	$I_{TM} = 2\,000\text{ A}$ $I_{TM} = 4\,000\text{ A}$			1.350 1.610	V
V_{T0}	Threshold voltage				1.198	V
r_T	Slope resistance	$I_{T1} = 4\,188\text{ A}$, $I_{T2} = 12\,563\text{ A}$			0.103	m Ω
I_{DM}	Peak off-state current	$V_D = V_{DRM}$			150	mA
I_{RM}	Peak reverse current	$V_R = V_{RRM}$			150	mA
t_{gd}	Delay time	$T_j = 25\text{ }^\circ\text{C}$, $V_D = 0.4 V_{DRM}$, $I_{TM} = I_{TAVm}$, $t_r = 0.3\text{ }\mu\text{s}$, $I_{GT} = 2\text{ A}$			2.0	μs
t_{q1}	Turn-off time	$I_T = 1\,000\text{ A}$, $di_T/dt = -50\text{ A}/\mu\text{s}$, $V_R = 100\text{ V}$, $V_D = 2/3 V_{DRM}$, $dv_D/dt = 50\text{ V}/\mu\text{s}$			60.0	μs
t_{q2}	Turn-off time	$I_T = 1\,000\text{ A}$, $di_T/dt = -25\text{ A}/\mu\text{s}$, $V_R = 100\text{ V}$, $V_D = 2/3 V_{DRM}$, $dv_D/dt = 400\text{ V}/\mu\text{s}$			80.0	μs
Q_{rr}	Recovery charge	the same conditions as at t_{q1}			2400	μC
I_{rrM}	Reverse recovery current	the same conditions as at t_{q1}			315	A
I_H	Holding current	$T_j = 25\text{ }^\circ\text{C}$ $T_j = 125\text{ }^\circ\text{C}$			250 150	mA
I_L	Latching current	$T_j = 25\text{ }^\circ\text{C}$ $T_j = 125\text{ }^\circ\text{C}$			500 300	mA
V_{GT}	Gate trigger voltage	$T_j = -40\text{ }^\circ\text{C}$ $T_j = 25\text{ }^\circ\text{C}$ $T_j = 125\text{ }^\circ\text{C}$		0.25	4 3 2	V
I_{GT}	Gate trigger current	$T_j = -40\text{ }^\circ\text{C}$ $T_j = 25\text{ }^\circ\text{C}$ $T_j = 125\text{ }^\circ\text{C}$		10	1000 500 300	mA

Unless otherwise specified $T_j = 125\text{ }^\circ\text{C}$

Thermal Parameters		Value	Unit
R_{thjc}	Thermal resistance junction to case <i>double side cooling</i>	10.0	K/kW
	<i>anode side cooling</i>	16.0	
	<i>cathode side cooling</i>	26.5	
R_{thch}	Thermal resistance case to heatsink <i>double side cooling</i>	3.0	K/kW
	<i>single side cooling</i>	6.0	

Transient Thermal Impedance

Analytical function for transient thermal impedance

$$Z_{thjc} = \sum_{i=1}^5 R_i (1 - \exp(-t/\tau_i))$$

Conditions:

$F_m = 50 \pm 5$ kN, Double side cooled

Correction for periodic waveforms

180° sine:	add 1.0 K/kW
180° rectangular:	add 1.0 K/kW
120° rectangular:	add 1.5 K/kW
60° rectangular:	add 3.0 K/kW

i	1	2	3	4	5
τ_i (s)	0.4871	0.1468	0.0677	0.0079	0.0021
R_i (K/kW)	6.73	1.44	0.65	0.84	0.32

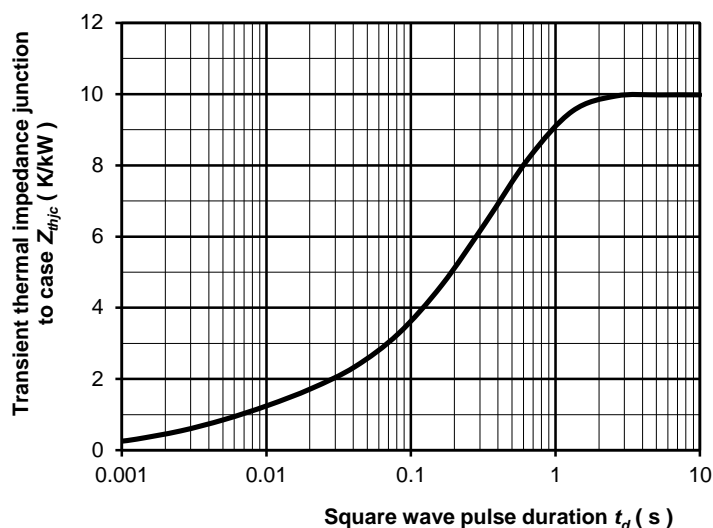


Fig. 2 Dependence transient thermal impedance junction to case on square pulse

On-State Characteristics

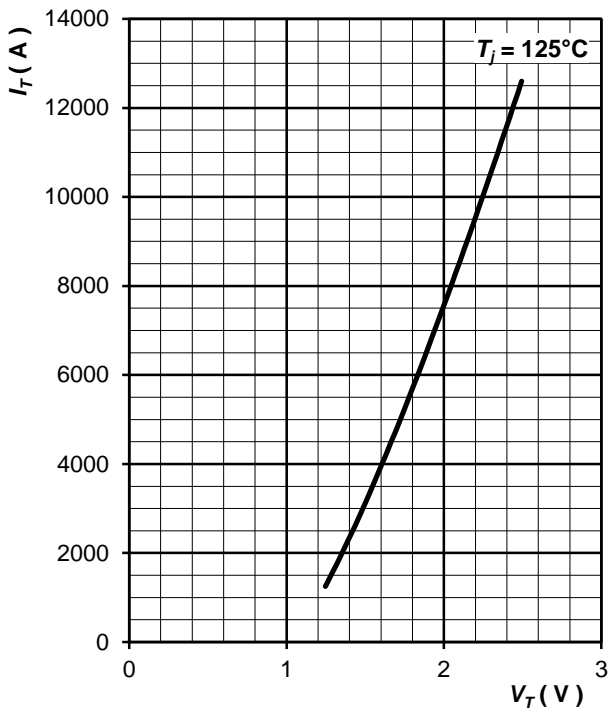


Fig. 3 Maximum on-state characteristics

Gate Trigger Characteristics

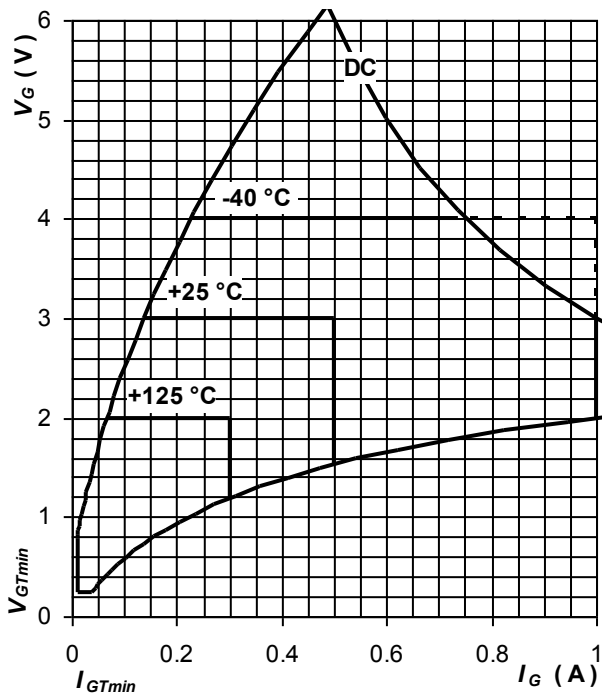


Fig. 4 Gate trigger characteristics

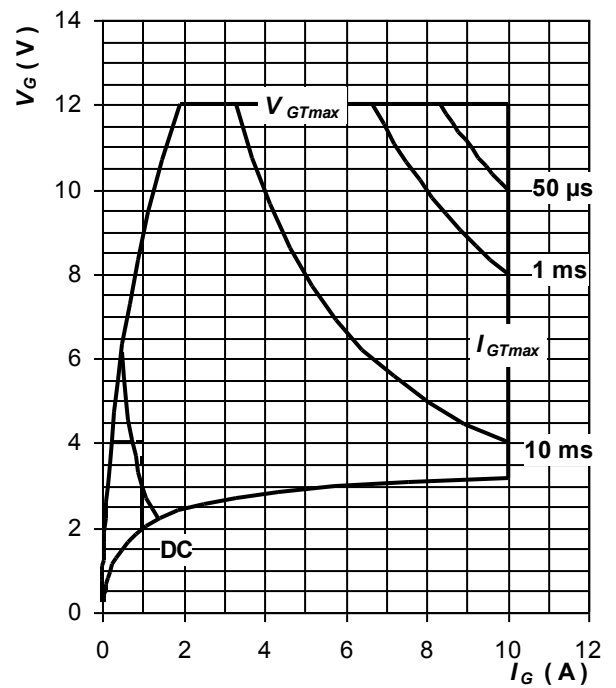


Fig. 5 Maximum peak gate power loss

Surge Characteristics

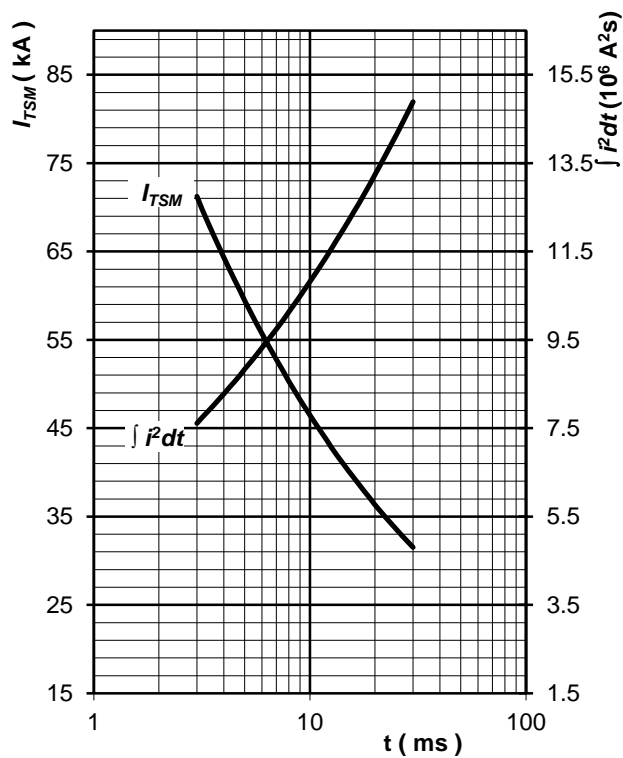


Fig. 6 Surge on-state current vs. pulse length, half sine wave, single pulse, $V_R = 0 V$, $T_j = T_{jmax}$

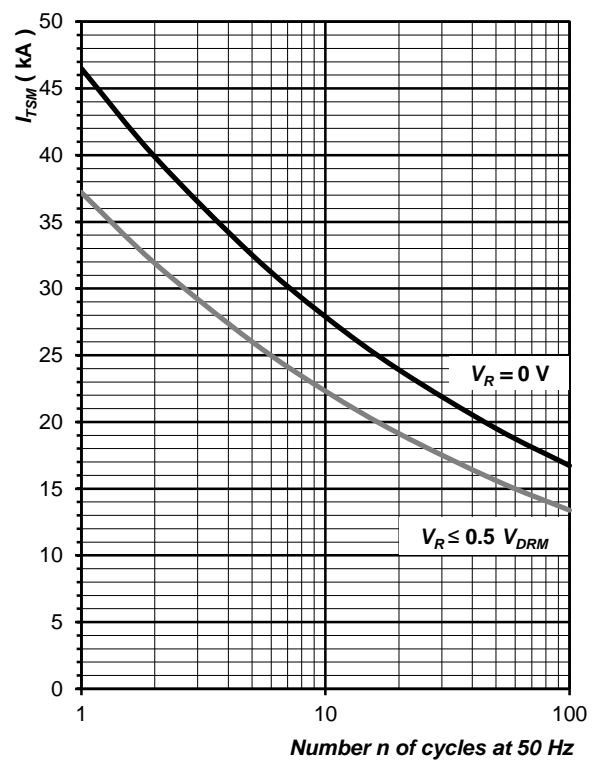


Fig. 7 Surge on-state current vs. number of pulses, half sine wave, $T_j = T_{jmax}$

Power Loss and Maximum Case Temperature Characteristics

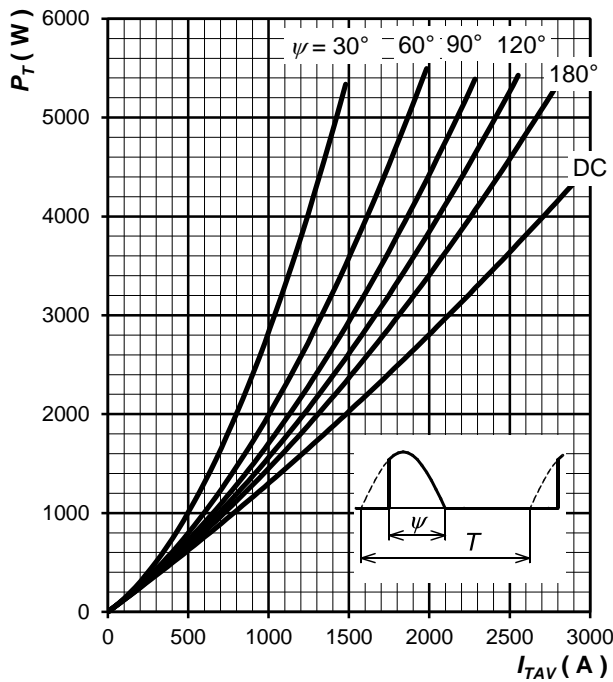


Fig. 8 On-state power loss vs. average on-state current, sine waveform, $f = 50 \text{ Hz}$, $T = 1/f$

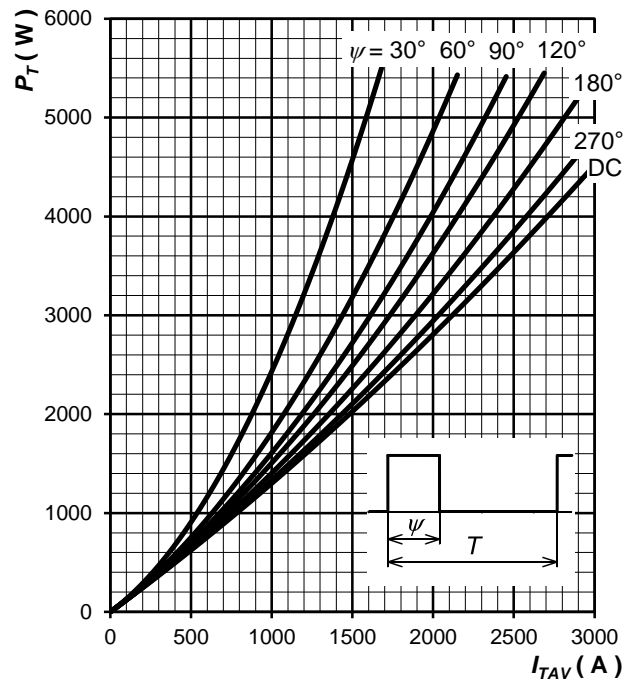


Fig. 9 On-state power loss vs. average on-state current, square waveform, $f = 50 \text{ Hz}$, $T = 1/f$

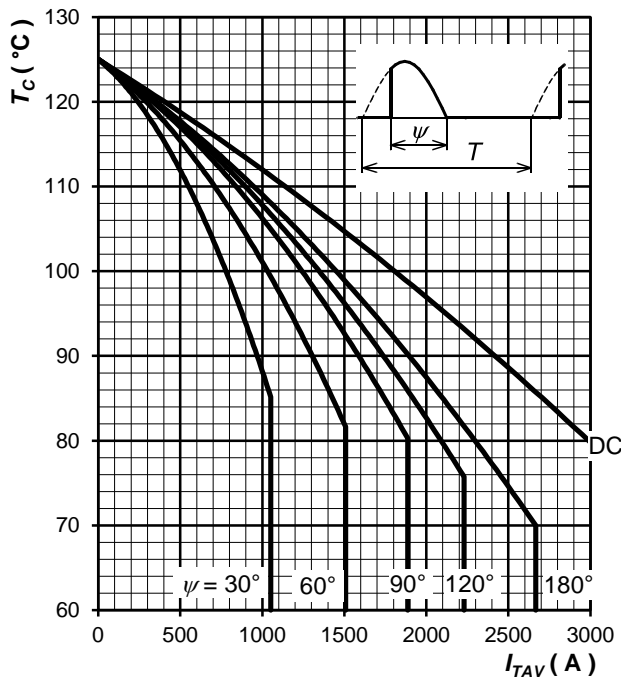


Fig. 10 Max. case temperature vs. aver. on-state current, sine waveform, $f = 50 \text{ Hz}$, $T = 1/f$

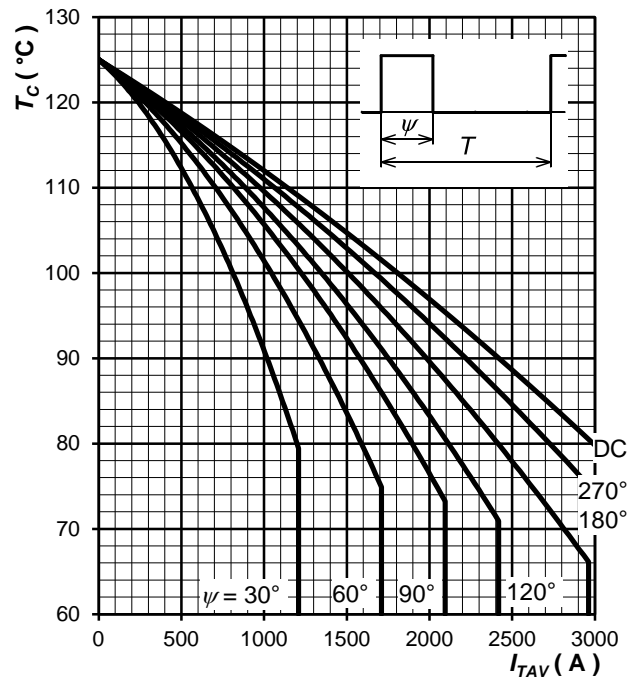


Fig. 11 Max. case temperature vs. aver. on-state current, square waveform, $f = 50 \text{ Hz}$, $T = 1/f$

Note 2: Figures number 8 ÷ 11 have been calculated without considering any turn-on and turn-off losses. They are valid for $f = 50$ or 60 Hz operation.

Turn-off Time, Parameter Relationship

Maximum values of turn-off time at application specific conditions are given by using this formula:

$$t_q = t_{q1} \cdot \frac{t_q(T_j)}{t_{q1}} \cdot \frac{t_q(dv_D/dt)}{t_{q1}} \cdot \frac{t_q(-di_T/dt)}{t_{q1}}$$

where:

t_{q1} is turn-off time at standard conditions, see section "Characteristics"

$\frac{t_q(T_j)}{t_{q1}}$ is factor to be taken from fig. 12

$\frac{t_q(dv_D/dt)}{t_{q1}}$ is factor to be taken from fig. 13

$\frac{t_q(-di_T/dt)}{t_{q1}}$ is factor to be taken from fig. 14

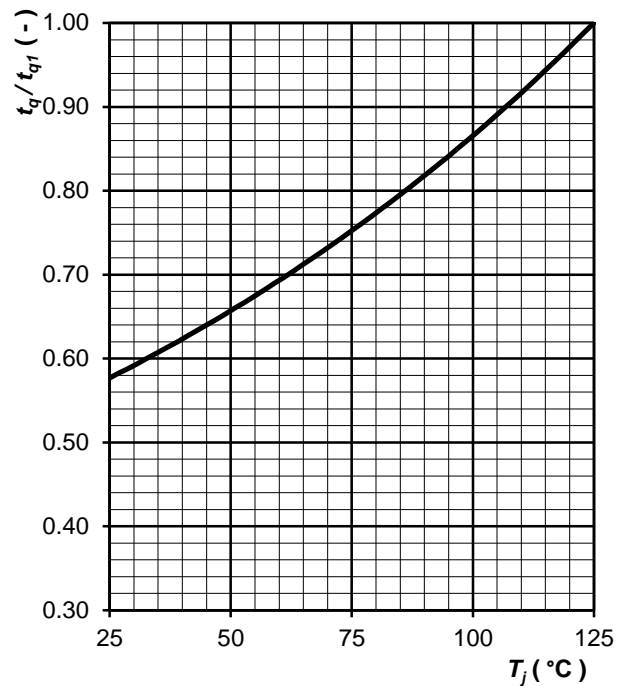


Fig. 12 Normalised maximum turn-off time vs. junction temperature

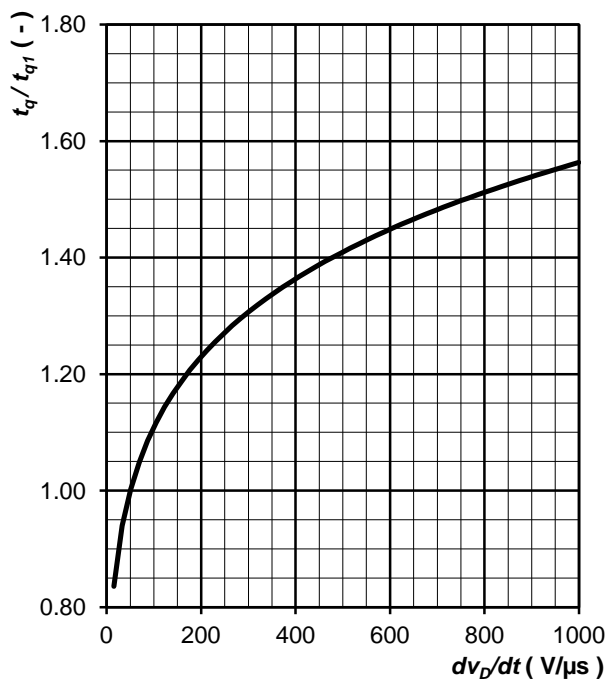


Fig. 13 Normalised maximum turn-off time vs. rate of rise of off-state voltage

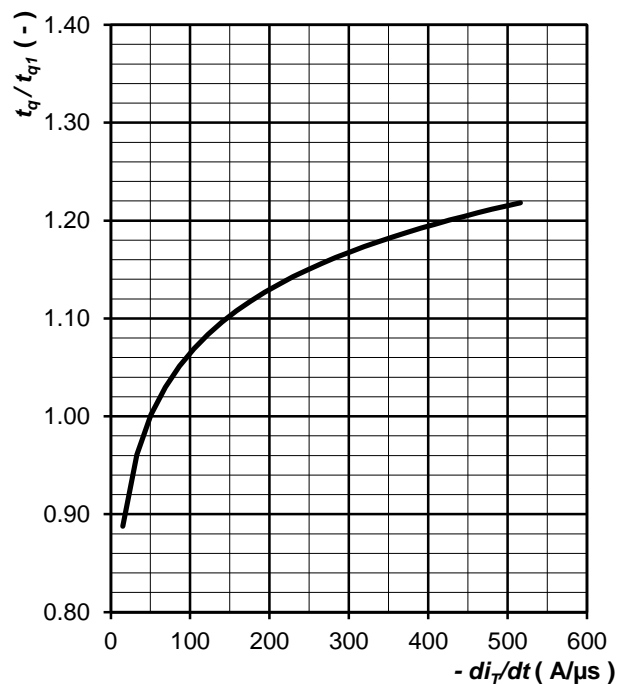


Fig. 14 Normalised maximum turn-off time vs. rate of fall of on-state current

Turn-off Characteristics

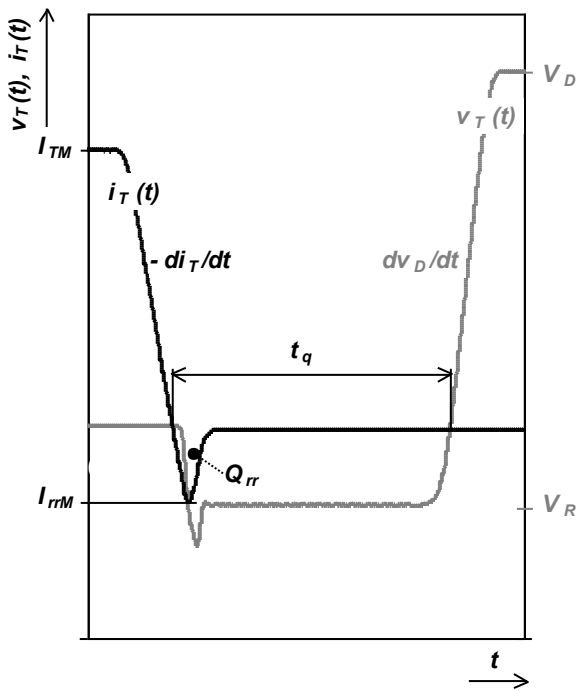


Fig. 17 Typical waveforms and definition of symbols at turn-off of a thyristor, inductive switching without RC snubber

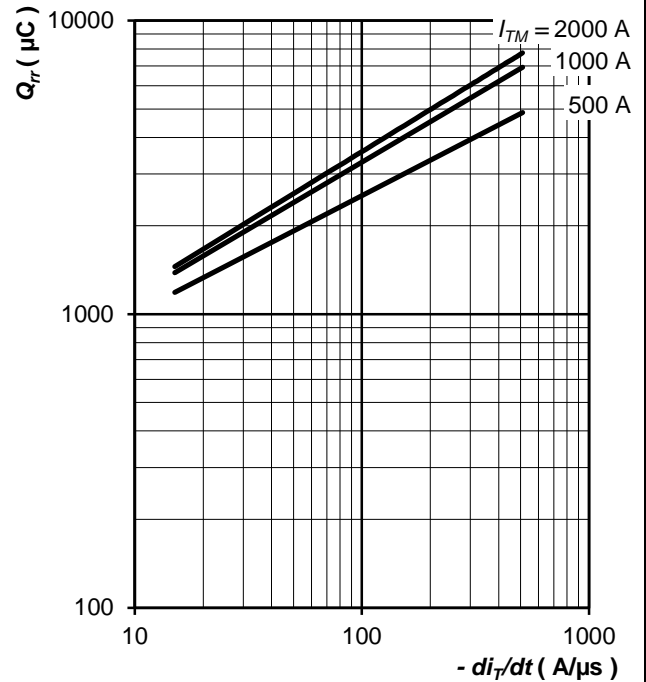


Fig. 18 Max. recovered charge vs. rate of fall on-state current, trapezoid pulse, $V_R = 100 \text{ V}$, $T_j = T_{jmax}$

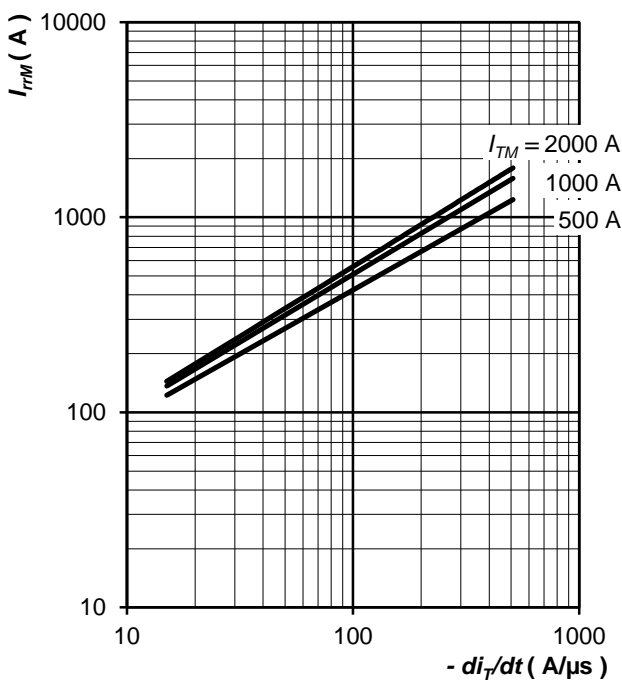


Fig. 19 Max. reverse recovery current vs. rate of fall on-state current, trapezoid pulse, $V_R = 100 \text{ V}$, $T_j = T_{jmax}$

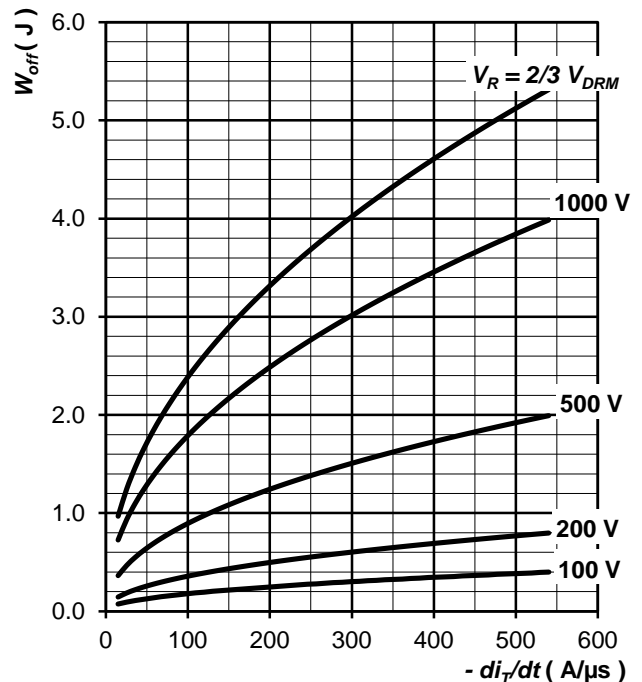


Fig. 20 Maximum turn-off energy per pulse vs. rate of fall on-state current, trapezoid pulse, inductive switching without RC snubber, $I_{TM} = 2\ 000 \text{ A}$, $T_j = T_{jmax}$

Notes:

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